IARIA

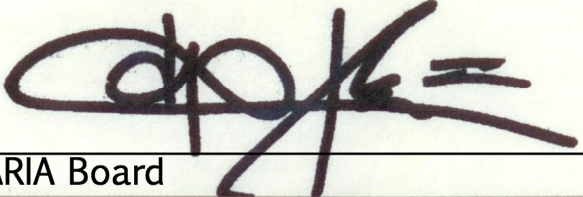International Academy, Research, and Industry Association

Best Paper Award

Calculating Test Coverage for BPEL Processes With
Process Log Analysis

By

Daniel Luebke

Presented during BUSTECH 2018, The Eighth International Conference on Business Intelligence and Technology,
held in Barcelona, Spain during February 18 - 22, 2018

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